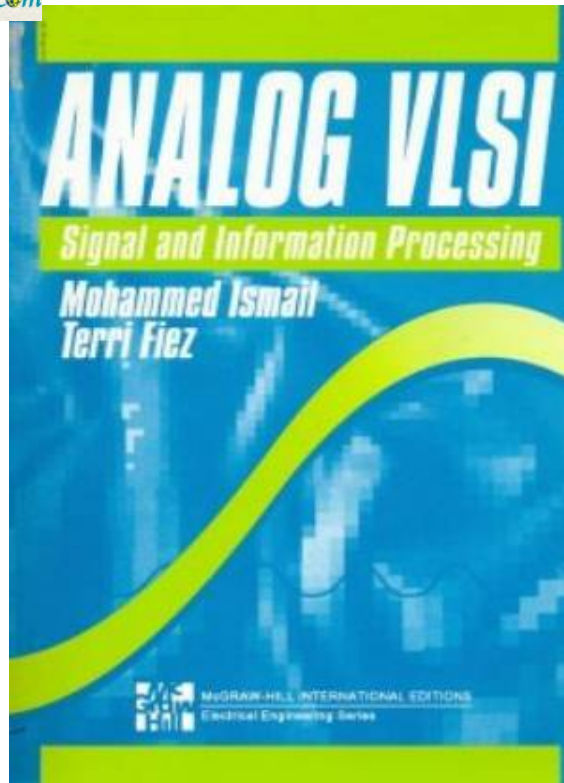




# ANALOG VLSI SIGNAL AND INFORMATION PROCESSING

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@inproceedings{Ismail1994AnalogV, title={Analog VLSI : signal and information processing}, author={Mohammed Ismail and Terri S. Fiez}, year={1994} }. Mohammed Ismail, Terri S. Fiez. Published 1994. CMOS analogue building blocks BiCMOS analogue building blocks sampled-data signal processing continuous-time signal processing current-mode signal processing analogue VLSI neural information processing data converters statistical modelling and simulation of analogue analogue CAD interconnects in analogue VLSI analogue VLSI design-for-test analogue integrated sensors.